

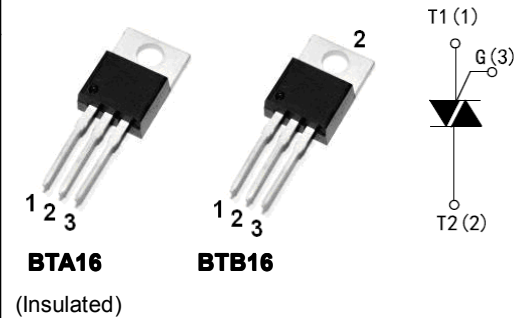
**BTA/BTB16**

**16A TRIACS**

DRAWING

Description

- Package: TO-220AB
- Available either in through-hole or surface-mount packages, the BTA/BTB16 is suitable for general purpose AC switching. They can be used as an ON/OFF function in application such as static relays, heating regulation ,Induction motor starting circuits...or for phase control operation in light dimmers, motor speed controllers.



**Absolute Maximum Ratings**

Symbol	Parameter	Value	Unit
I <sub>T(RMS)</sub>	RMS on-state current(full sine wave)	TO-220AB TC=100°C	16 A
		TO-220AB Ins. TC=85°C	
I <sub>TSM</sub>	Non repetitive surge peak on-state current(full cycle, T <sub>j</sub> initial=25°C)	F=50Hz t=20ms	160 A
		F=60Hz t=16.7ms	168 A
I <sup>2</sup> t	I <sup>2</sup> t Value for fusing	tp=10ms	144 A <sup>2</sup> s
DI/DT	Critical rate of rise of on-state current IG=2XIGT, tr≤100ns	F=120Hz Tj=125°C	50 A/us
V <sub>D</sub> SM/V <sub>RSM</sub>	Non repetitive surge peak off-state voltage	tp=10ms Tj=25°C	V <sub>drm</sub> / v <sub>rrm</sub> + 100V V
I <sub>GM</sub>	Peak gate current	tp=20us Tj=125°C	4 A
P <sub>G(AV)</sub>	Average gate power dissipation	Tj=125°C	1 W
T <sub>stg</sub>	Storage junction temperature range		-40 to +150 °C
T <sub>j</sub>	Operating junction temperature range		-40 to +125 °C

**Electrical Characteristics (T<sub>j</sub>=25°C, unless otherwise specified)**

**Snubberless™ and Logic Level(3 quadrants)**

Symbol	Test conditions	Quadrant	BTA16		Unit
I <sub>GT</sub> (1)	V <sub>D</sub> =12V R <sub>L</sub> =33Ω	I - II - III	MAX	50	mA
V <sub>GT</sub>		I - II - III	MAX	1.3	V
V <sub>GD</sub>	V <sub>D</sub> =V <sub>DRM</sub> R <sub>L</sub> =3.3KΩ Tj=125°C	I - II - III	MIN	0.2	V
I <sub>H</sub> (2)	I <sub>T</sub> =500mA		MAX	50	mA
I <sub>L</sub>	I <sub>G</sub> =1.2I <sub>GT</sub>	I - III	MAX	70	mA
		II		80	
Dv / Dt(2)	V <sub>D</sub> =67%V <sub>DRM</sub> Gate open Tj=125°C		MIN	1000	V/us
(DI/dt) <sub>c</sub> (2)	(Dv/dt) <sub>c</sub> =0.1 V/us Tj=125°C		MIN	-	A/ms
	(Dv/dt) <sub>c</sub> =10V/us Tj=125°C			-	
	Without snubber Tj=125°C			14	

**Standard (4 Quadrants)**

Symbol	Test conditions	Quadrant	BTA12		Unit
IGT(1)	VD=12V RL=33Ω	I - II - III	MAX	50	mA
VGT		IV		100	
VGD	VD=VDRM RL=3.3KΩTj=125°C	ALL	MAX	1.3	V
IH(2)	IT=500mA		MIN	0.2	V
IL	IG=1.2IGT	I - III- IV	MAX	60	mA
		II		120	
(DI/dt)(2)	VD=67%VDRM Gate open Tj=125°C		MIN	400	V/us
(DI/dt)c(2)	(Dv/dt)c=7 A/ms Tj=125°C		MIN	10	V/us

**Static Characteristics**

Symbol	Test conditions			Value	Unit
V <sub>TM</sub> (2)	ITM=11A tp=380us	TJ=25°C	MAX	1.55	V
V <sub>to</sub> (2)	Threshold voltage	TJ=125°C	MAX	0.85	V
R <sub>d</sub> (2)	Dynamic resistance	TJ=125°C	MAX	25	mΩ
I <sub>DRM</sub>	V <sub>DRM</sub> =V <sub>R<sub>RM</sub></sub>	TJ=25°C		5	uA
I <sub>R<sub>RM</sub></sub>		TJ=125°C	MAX	2	mA
V <sub>DRM</sub> /V <sub>R<sub>RM</sub></sub>	Voltage	TJ=25°C	MIN	600 and 800	V

**Note 1:** minimum IGT is guaranteed at 5% of IGT max

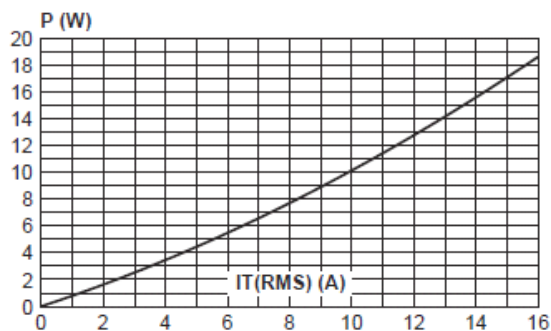
**Note 2:** for both polarities of A2 referenced to A1

**Thermal Resistances**

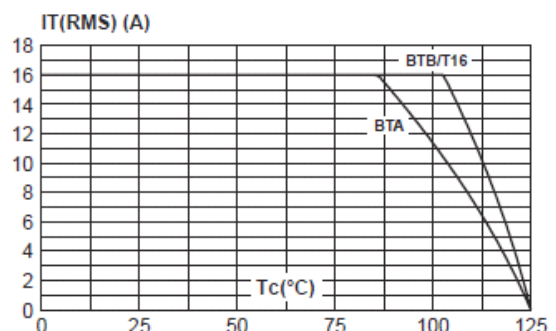
Symbol	Parameter		Value	Unit
R <sub>th(j-c)</sub>	Junction to case(AC)	TO-220AB	1.2	°C/W
		TO-220AB(Insulated)	2.1	
R <sub>th(j-a)</sub>	Junction to ambient	TO-220AB/ TO-220AB(Insulated)	60	°C/W

**Typical Characteristics**

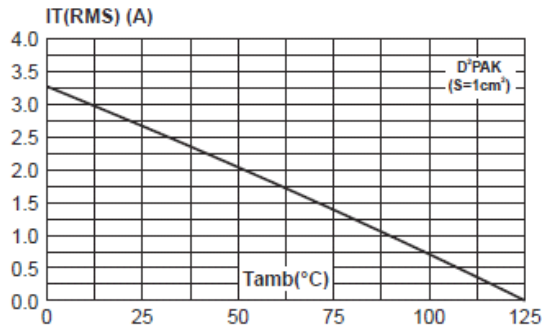
**Fig. 1:** Maximum power dissipation versus RMS on-state current (full cycle).



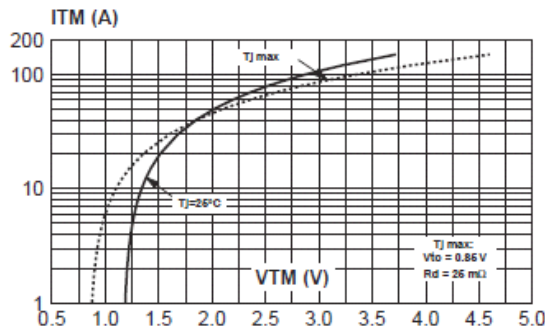
**Fig. 2-1:** RMS on-state current versus case temperature (full cycle).



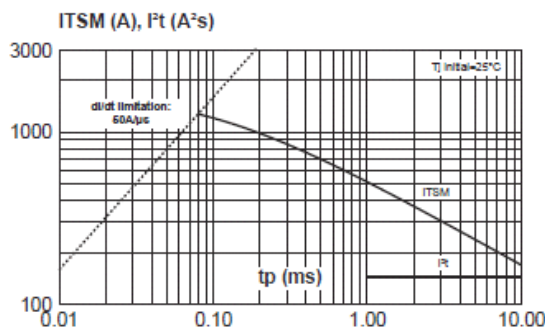
**Fig. 2-2:** D<sup>2</sup>PAK RMS on-state current versus ambient temperature (printed circuit board FR4, copper thickness: 35 μm), full cycle.



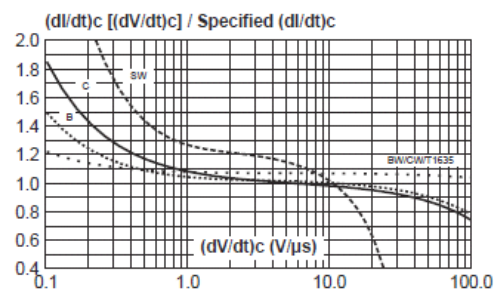
**Fig. 4:** On-state characteristics (maximum values)



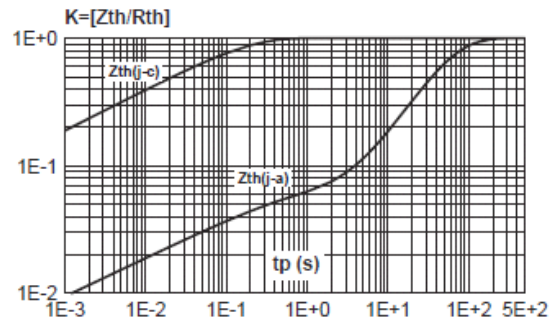
**Fig. 6:** Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 10\text{ms}$ , and corresponding value of  $I^2t$ .



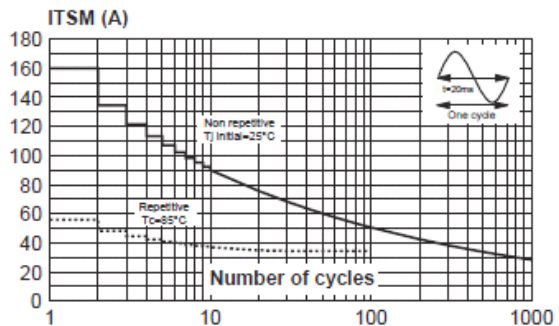
**Fig. 8:** Relative variation of critical rate of decrease of main current versus  $(dV/dt)_c$  (typical values).



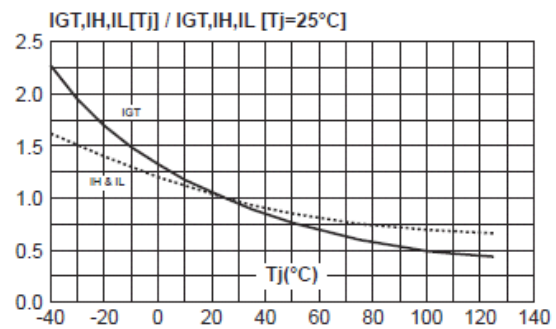
**Fig. 3:** Relative variation of thermal impedance versus pulse duration.



**Fig. 5:** Surge peak on-state current versus number of cycles.



**Fig. 7:** Relative variation of gate trigger current, holding current and latching current versus junction temperature (typical values).



**Fig. 9:** Relative variation of critical rate of decrease of main current versus junction temperature.

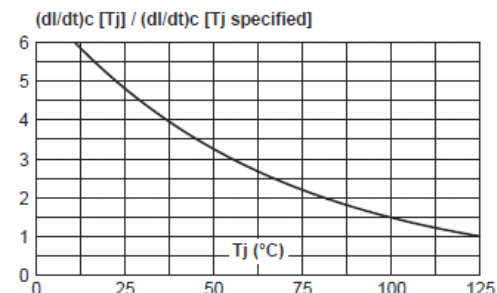
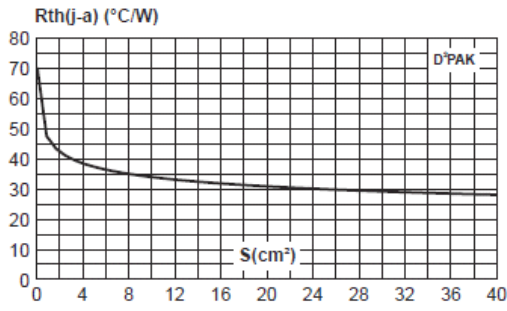


Fig. 10:D<sup>2</sup>PAK Thermal resistance junction to ambient versus copper surface under tab (printed circuit board FR4, copper thickness: 35 μm).



Package Mechanical Data

